

DK-106349-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Intel[®] NUC (Mini PC)

INTEL CORPORATION 2200 Mission College Blvd Santa Clara, CA 95054 USA

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MAINTEK COMPUTER (SUZHOU) CO LTD 233 JIN FENG RD NEW DISTRICT SUZHOU JIANGSU 215011 CHINA

Additional Information on page 2

19.5Vdc, 11.8A or 19.5Vdc, 16.9A

Ratings and principal characteristics

Trademark / Brand (if any)

INTEL



Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

NUC11PH, xNUC11PHx, xNUC11PHy (where x and y can be a combination of alphanumeric characters or blank)

Additionally evaluated to EN 62368-1:2014/A11: 2017 National Difference specified in the CB Test Report

IEC 62368-1:2014

ASL20082140 issued on 2020-11-20

This CB Test Certificate is issued by the National Certification Body

U	UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA
Date: 2020-11-27	For full legal entity names see www.ul.com/ncbnames

Jan-Erik Storgaard